# Power MOSFET 23 Amps, 25 Volts

### N-Channel D<sup>2</sup>PAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

#### **Typical Applications**

- Planar HD3e Process for Fast Switching Performance
- Low R<sub>DS(on)</sub> to Minimize Conduction Loss
- Low C<sub>iss</sub> to Minimize Driver Loss
- Low Gate Charge
- Optimized for High Side Switching Requirements in High–Efficiency DC–DC Converters

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	25	Vdc
Gate-to-Source Voltage - Continuous	V <sub>GS</sub>	±20	Vdc
	I <sub>D</sub> I <sub>DM</sub>	23 6.0 60	A
Total Power Dissipation @ T <sub>A</sub> = 25°C	P <sub>D</sub>	37.5	W
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Thermal Resistance – Junction–to–Case	$R_{\theta JC}$	3.3	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	$T_L$	260	ů

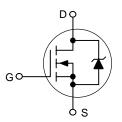


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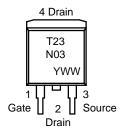
#### 23 AMPERES, 25 VOLTS $R_{DS(on)} = 32 \text{ m}\Omega \text{ (Typ)}$

N-CHANNEL





## MARKING DIAGRAM & PIN ASSIGNMENTS



T23N03 = Specific Device Code

Y = Year WW = Work Week

#### **ORDERING INFORMATION**

Device	Package	Shipping	
NTB23N03R	D <sup>2</sup> PAK	50 Units/Rail	
NTB23N03RT4	D <sup>2</sup> PAK	800/Tape & Reel	

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25$ °C unless otherwise specified)

Characteristics		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		-		-	-	-
Drain-to-Source Breakdown Voltage (Note 1) (V <sub>GS</sub> = 0 Vdc, I <sub>D</sub> = 250 μAdc) Temperature Coefficient (Positive)		V(br) <sub>DSS</sub>	25 -	28 -	_ _	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 150^{\circ}\text{C})$		I <sub>DSS</sub>	_ _	- -	1.0 10	μAdc
Gate–Body Leakage Current (V <sub>GS</sub> = ±20 Vdc, V <sub>DS</sub> = 0 Vdc)		I <sub>GSS</sub>	-	-	±100	nAdc
ON CHARACTERISTICS (Note 1)						
Gate Threshold Voltage (Note 1) $(V_{DS} = V_{GS}, I_D = 250 \mu Ad$ Threshold Temperature Coefficient (		V <sub>GS(th)</sub>	1.0	1.8 -	2.0	Vdc mV/°C
Static Drain-to-Source On-Resista $(V_{GS} = 4.5 \text{ Vdc}, I_D = 6 \text{ Add})$ $(V_{GS} = 10 \text{ Vdc}, I_D = 6 \text{ Add})$	c)	R <sub>DS(on)</sub>	- -	50.3 32.3	60 45	mΩ
Forward Transconductance (Note 1) (V <sub>DS</sub> = 10 Vdc, I <sub>D</sub> = 6 Adc)		9FS	1	14	-	Mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C <sub>iss</sub>	-	225	_	pF
Output Capacitance	$(V_{DS} = 20 \text{ Vdc}, V_{GS} = 0 \text{ V, f} = 1 \text{ MHz})$	C <sub>oss</sub>	-	108	_	
Transfer Capacitance		C <sub>rss</sub>	_	48	_	
SWITCHING CHARACTERISTICS	(Note 2)					
Turn-On Delay Time		t <sub>d(on)</sub>	-	2.0	_	ns
Rise Time	(V <sub>GS</sub> = 10 Vdc, V <sub>DD</sub> = 10 Vdc,	t <sub>r</sub>	-	14.9	_	
Turn-Off Delay Time	$I_D = 6 \text{ Adc}, R_G = 3 \Omega$	t <sub>d(off)</sub>	-	9.9	_	
Fall Time		t <sub>f</sub>	-	2.0	_	
Gate Charge	$(V_{GS} = 4.5 \text{ Vdc}, I_D = 6 \text{ Adc},$ $V_{DS} = 10 \text{ Vdc}) \text{ (Note 1)}$	Q <sub>T</sub>	-	3.76	_	nC
		Q <sub>1</sub>	-	1.7	_	
		Q <sub>2</sub>	_	1.6	_	
SOURCE-DRAIN DIODE CHARAC	TERISTICS					
Forward On-Voltage	$(I_S = 6 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 1)}$ $(I_S = 6 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V <sub>SD</sub>	1 1	0.87 0.74	1.2 -	Vdc
Reverse Recovery Time		t <sub>rr</sub>	-	8.7	_	ns
	$(I_S = 6 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$	ta	-	5.2	_	
	dl <sub>S</sub> /dt = 100 A/μs) (Note 1)	t <sub>b</sub>	-	3.5	_	
Reverse Recovery Stored Charge		Q <sub>RR</sub>	_	0.003	_	μC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

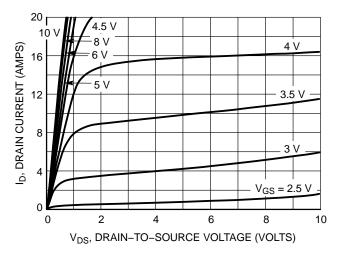
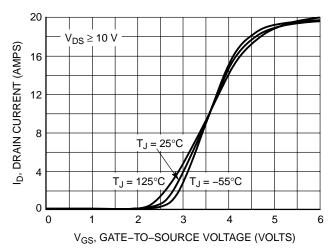


Figure 1. On-Region Characteristics



**Figure 2. Transfer Characteristics** 

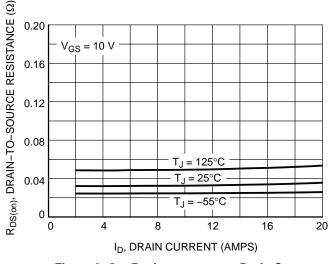


Figure 3. On–Resistance versus Drain Current and Temperature

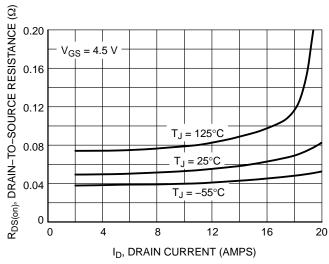


Figure 4. On-Resistance versus Drain Current and Temperature

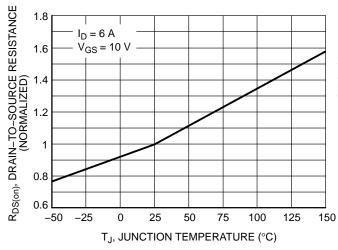


Figure 5. On–Resistance Variation with Temperature

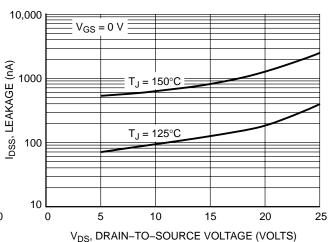


Figure 6. Drain-to-Source Leakage Current versus Voltage

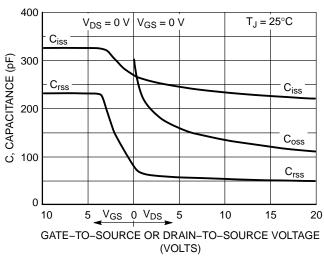


Figure 7. Capacitance Variation

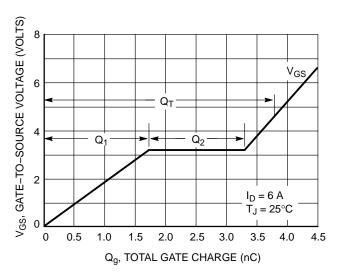


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

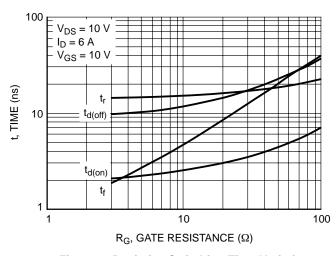


Figure 9. Resistive Switching Time Variation versus Gate Resistance

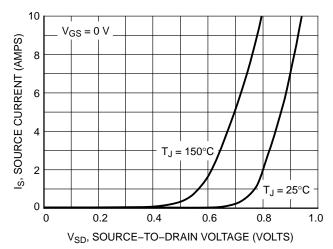
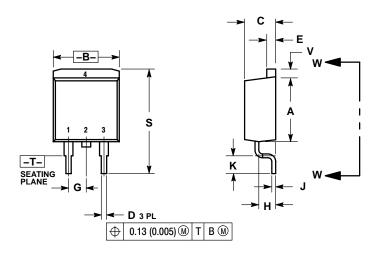
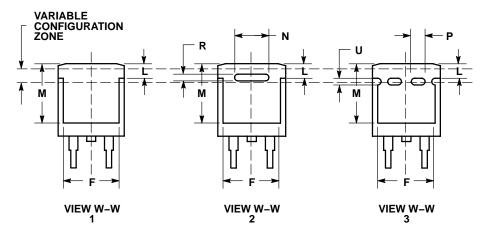


Figure 10. Diode Forward Voltage versus Current

#### **PACKAGE DIMENSIONS**

#### D<sup>2</sup>PAK CASE 418B-04 **ISSUE H**



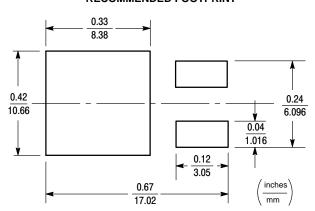


- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
  3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
C	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
Е	0.045	0.055	1.14	1.40
F	0.310	0.350	7.87	8.89
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03	2.79
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
L	0.052	0.072	1.32	1.83
M	0.280	0.320	7.11	8.13
N	0.197 REF		5.00 REF	
Р	0.079	REF	2.00 REF	
R	0.039	REF	0.99 REF	
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40

## STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

#### RECOMMENDED FOOTPRINT



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